Spallation Neutron Source



MAGNETISM REFLECTOMETER

The Magnetism Reflectometer is designed for reflectometry and high-angle diffraction studies of magnetic thin films, superlattices, and surfaces. The combination of the high-power SNS and the use of advanced neutron optics allows for off-specular diffraction studies of in-plane structures. Today, even at the world's most advanced neutron sources, such experiments are extremely difficult to perform. The availability of polarized neutrons and polarization analysis suggests that this instrument can also be used for specific studies of nonmagnetic thin-film samples. Examples of the latter include contrast variation, incoherent background reduction, and phase determination for direct inversion of

Electronics racks Sample stage Removable and shielding roof sample magnet (suppressed) Incident beam line shielding (with neutron guide and bandwidth choppers) Instrument control hutch Shielding wall toward Liquids Reflectometer (suppressed)

reflectivity data into real-space scatteringlength density profiles.

SPECIFICATIONS

Source- to-sample distance	18.64 m
Sample- to-detector distance	0.5–6 m
Detector size	18 x 18 cm ²
Detector resolution	1.5 mm
Moderator	Coupled supercritical hydrogen
Bandwidth	$\Delta\lambda=3.1~\text{Å}$
Wavelength range	1.8 Å < λ < 14.0 Å
Q range	0 Å-1 < Q <
Q range	7.0 Å ⁻¹

Status: Operational

APPLICATIONS

The Magnetism Reflectometer is applicable primarily to studies with thin magnetic films, an increasingly important area of solid-state physics. Experiments could also benefit engineering, metallurgy, or biological problems. Instrument capabilities allow, for example, studies of magnetic recording media and magnetic sensors, as well as depth-dependent studies of structural/magnetic nanoparticles or domains. The instrument's unique capabilities provide for multilength-scale experiments, and it has sufficient beam intensity for detailed structural/magnetic phase-diagram determinations. In situ studies on ultrathin films in an ultrahigh-vacuum environment are planned as a future upgrade capability.

FOR MORE INFORMATION, CONTACT

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http://neutrons.ornl.gov/instrument systems/beamline 04a mr

